


Search Notes 	Application/Control No. 10695887	Applicant(s)/Patent Under Reexamination MEYER ET AL.
	Examiner Nawaz, Asad M	Art Unit 2455

SEARCHED

Class	Subclass	Date	Examiner
709	201-203, 220-223	9/17/07	AMN
709	200,201-203,208-211,213-216,223-226,229,245-246,248-249	9/23/09	AMN
711	1-6, 111-114, 148, 202-203, 209	9/23/09	AMN
710	2	9/23/09	AMN
709	200,201-203,208-211,213-216,223-226,229,245-246,248-249	2/15/10	AMN
711	1-6, 111-114, 202-203, 209	2/15/10	AMN
710	2	2/15/10	AMN

SEARCH NOTES

Search Notes	Date	Examiner
East Search (USPAT; USPGPUB)	9/17/07	AMN
Inventor Name Search for ODP	9/17/07	AMN
updated East search	7/20/09	AMN
Consulted SPE Saleh Najjar regarding response strategy and allowability	9/23/09	AMN
Consulted Primary Examiner Abdullahi Salad regarding search strategy and classification	9/23/09	AMN
Consulted SPE Tom Lee regarding classification and allowability	9/23/09	AMN
Consulted SPE Kevin Ellis regarding search strategy and allowability	9/23/09	AMN
Consulted QAS Kim Huynh regarding restriction and response strategy	9/23/09	AMN
Conducted thorough EAST and NPL search	9/23/09	AMN
Consulted Primary Shawki Ismail regarding allowability	2/4/10	AMN
Conducted East Search (USPAT; USPGPUB; USOCR; USPAD; FPRS; JPO; EPO; DERWENT; IBM_TDB)	2/4/10	AMN
INVENTOR NAME SEARCH FOR ODP	2/4/10	AMN
Consulted QAS Chris Grant regarding 101 issues	2/4/10	AMN
East Search, updated	2/15/10	AMN
NPL Search (IEEE Xplore, ACM Digital Library, Google)	2/15/10	AMN

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
711	1-6, 111-114, 148, 202-203, 209	2/15/10	AMN

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INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
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710	2	2/15/10	AMN

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